

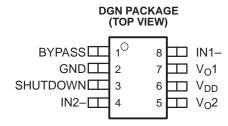


Check for Samples: TPA6110A2

FEATURES

- 150 mW Stereo Output
- PC Power Supply Compatible
 - Fully Specified for 3.3 V and 5 V Operation
 - Operation to 2.5 V
- Pop Reduction Circuitry
- Internal Mid-Rail Generation
- · Thermal and Short-Circuit Protection

- Surface-Mount Packaging
 - PowerPAD™ MSOP
- Pin Compatible With LM4881

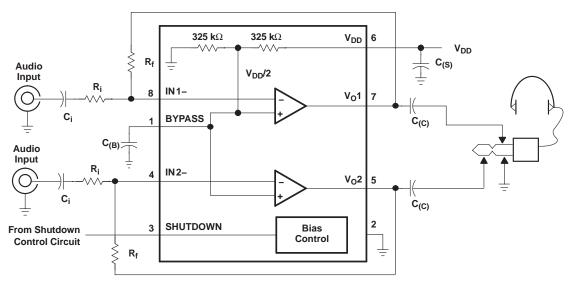


DESCRIPTION

The TPA6110A2 is a stereo audio power amplifier packaged in an 8-pin PowerPAD™ MSOP package capable of delivering 150 mW of continuous RMS power per channel into 16-Ω loads. Amplifier gain is externally configured by means of two resistors per input channel and does not require external compensation for settings of 1 to 10.

THD+N when driving a 16- Ω load from 5 V is 0.03% at 1 kHz, and less than 1% across the audio band of 20 Hz to 20 kHz. For 32- Ω loads, the THD+N is reduced to less than 0.02% at 1 kHz, and is less than 1% across the audio band of 20 Hz to 20 kHz. For 10-k Ω loads, the THD+N performance is 0.005% at 1 kHz, and less than 0.5% across the audio band of 20 Hz to 20 kHz.

TYPICAL APPLICATION CIRCUIT



M

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PowerPAD is a trademark of Texas Instruments.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

AVAILABLE OPTIONS

т	PACKAGED DEVICE	MSOP SYMBOLIZATION
I A	MSOP ⁽¹⁾	MSOP STMBOLIZATION
-40°C to 85°C	TPA6110A2DGN	TI AIZ

(1) The DGN package is available in left-ended tape and reel only (e.g., TPA6110A2DGNR).

PinFunctions

PIN		1/0	DESCRIPTION
NAME	NO.	1/0	DESCRIPTION
BYPASS	1	I	Tap to voltage divider for internal mid-supply bias supply. Connect to a 0.1 μ F to 1 μ F low ESR capacitor for best performance.
GND	2	I	GND is the ground connection.
IN1-	8	I	IN1– is the inverting input for channel 1.
IN2-	4	I	IN2– is the inverting input for channel 2.
SHUTDOWN	3	- 1	Puts the device in a low quiescent current mode when held high.
V_{DD}	6	- 1	V _{DD} is the supply voltage terminal.
V _O 1	7	0	V _O 1 is the audio output for channel 1.
V _O 2	5	0	V _O 2 is the audio output for channel 2.

ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

		UNIT
V_{DD}	Supply voltage	6 V
V_{I}	Input voltage	–0.3 V to V _{DD} + 0.3 V
	Continuous total power dissipation	Internally limited
T _J	Operating junction temperature range	-40°C to 150°C
T _{stg}	Storage temperature range	-65°C to 150°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING FACTOR	T _A = 70°C	T _A = 85°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING	POWER RATING
DGN	2.14 W ⁽¹⁾	17.1 mW/°C	1.37 W	1.11 W

⁽¹⁾ See the Texas Instruments document, PowerPAD Thermally Enhanced Package Application Report (SLMA002), for more information on the PowerPAD™ package. The thermal data was measured on a PCB layout based on the information in the section entitled Texas Instruments Recommended Board for PowerPAD on page 33 of the before mentioned document.

RECOMMENDED OPERATING CONDITIONS

	MINIERDED OF ERVATING CONDITIONS			
		MIN	MAX	UNIT
V_{DD}	Supply voltage	2.5	5.5	V
T_A	Operating free-air temperature	-40	85	°C
V_{IH}	High-level input voltage (SHUTDOWN)	60% x V _{DD}		V
V_{IL}	Low-level input voltage (SHUTDOWN)		25% x V _{DD}	V

Product Folder Link(s): TPA6110A2



DC ELECTRICAL CHARACTERISTICS

at $T_A = 25$ °C, $V_{DD} = 2.5$ V (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Voo	Output offset voltage	A _V = 2 V/V			15	mV
PSRR	Power supply rejection ratio	V _{DD} = 3.2 V to 3.4 V		83		dB
I _{DD}	Supply current	SHUTDOWN = 0 V		1.5	3	mA
I _{DD(SD)}	Supply current in shutdown mode	SHUTDOWN = V _{DD}		1	10	μA

AC OPERATING CHARACTERISTICS

 $V_{DD} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}, R_L = 16 \Omega$

	PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT
Po	Output power (each channel)	THD≤ 0.1%, f = 1 kHz	60	mW
THD+N	Total harmonic distortion + noise	P _O = 40 mW, 20 - 20 kHz	0.4%	
B _{OM}	Maximum output power BW	G = 10, THD < 5%	> 20	kHz
	Phase margin	Open loop	96°	
	Supply ripple rejection ratio	f = 1 kHz	71	dB
	Channel/channel output separation	f = 1 kHz, P _O = 40 mW	89	dB
SNR	Signal-to-noise ratio	P _O = 50 mW, A _V = 1	100	dB
V _n	Noise output voltage	A _V = 1	11	μV(rms)

DC ELECTRICAL CHARACTERISTICS

at $T_A = 25$ °C, $V_{DD} = 5.5$ V (unless otherwise noted)

αι . _A – <u>-</u>	17A = 25 C; V _{DD} = 5.5 V (difference fiction)						
	PARAMETER	TEST CONDITIONS	MIN TY	MAX	UNIT		
Voo	Output offset voltage	A _V = 2 V/V		15	mV		
PSRR	Power supply rejection ratio	V _{DD} = 4.9 V to 5.1 V	7	3	dB		
I _{DD}	Supply current	SHUTDOWN = 0 V	1.	5 3	mA		
I _{DD(SD)}	Supply current in shutdown mode	SHUTDOWN = V _{DD}		1 10	μΑ		
I _{IH}	High-level input current (SHUTDOWN)	$V_{DD} = 5.5 \text{ V}, V_{I} = V_{DD}$		1	μΑ		
I _{IL}	Low-level input current (SHUTDOWN)	V _{DD} = 5.5 V, V _I = 0 V		1	μΑ		
Zi	Input impedance		>	1	МΩ		

AC OPERATING CHARACTERISTICS

 $V_{DD} = 5 \text{ V. } T_{\Lambda} = 25^{\circ}\text{C. } R_{L} = 16 \Omega$

VDD = 0 V, 14 = 20 O, 14 = 10 32						
	PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT		
Po	Output power (each channel)	THD≤ 0.1%, f = 1 kHz	150	mW		
THD+N	Total harmonic distortion + noise	P _O = 100 mW, 20 - 20 kHz	0.6%			
B _{OM}	Maximum output power BW	G = 10, THD < 5%	> 20	kHz		
	Phase margin	Open loop	96°			
	Supply ripple rejection ratio	f = 1 kHz	61	dB		
	Channel/Channel output separation	f = 1 kHz, P _O = 100 mW	90	dB		
SNR	Signal-to-noise ratio	P _O = 100 mW, A _V = 1	100	dB		
V _n	Noise output voltage	A _V = 1	11.7	μV(rms)		

AC OPERATING CHARACTERISTICS

 $V_{DD} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}, R_L = 32 \Omega$

PARAME	TER	TEST CONDITIONS	MIN TYP MAX	UNIT
Po	Output power (each channel)	THD≤ 0.1%, f = 1 kHz	40	mW
THD+N	Total harmonic distortion + noise	P _O = 30 mW, 20 - 20 kHz	0.4%	
B _{OM}	Maximum output power BW	A _V = 10, THD < 2%	> 20	kHz

Copyright © 2000–2011, Texas Instruments Incorporated



AC OPERATING CHARACTERISTICS (continued)

 $V_{DD}=3.3~V,~T_A=25^{\circ}C,~R_L=32~\Omega$

PARAM	IETER	TEST CONDITIONS	MIN TYP	MAX UN	NIT
	Phase margin	Open loop	96°		
	Supply ripple rejection ratio	f = 1 kHz	71	d	ΙB
	Channel/channel output separation	f = 1 kHz	95	d	ΙB
SNR	Signal-to-noise ratio	$P_{O} = 40 \text{ mW}, A_{V} = 1$	100	d	ΙB
V _n	Noise output voltage	A _V = 1	11	μV(ı	rms)

AC OPERATING CHARACTERISTICS

 V_{DD} = 5 V, T_A = 25°C, R_L = 32 Ω

PARAME	TER	TEST CONDITIONS	MIN TYP MAX	UNIT
Po	Output power (each channel)	THD≤ 0.1%, f = 1 kHz	90	mW
THD+N	Total harmonic distortion + noise	$P_0 = 60 \text{ mW}, 20 - 20 \text{ kHz}$	0.4%	
B _{OM}	Maximum output power BW	A _V = 10, THD < 2%	> 20	kHz
	Phase margin	Open loop	97°	
	Supply ripple rejection ratio	f = 1 kHz	61	dB
	Channel/channel output separation	f = 1 kHz	98	dB
SNR	Signal-to-noise ratio	$P_{O} = 90 \text{ mW}, A_{V} = 1$	100	dB
V _n	Noise output voltage	A _V = 1	11.7	μV(rms)

TYPICAL CHARACTERISTICS

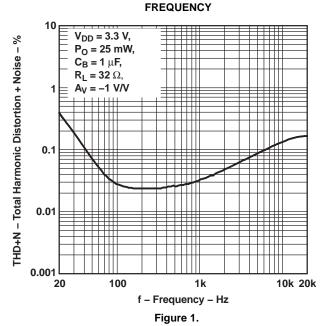
Table of Graphs

			FIGURE		
THD+N	Total harmonia distantian plus poiss	vs Frequency	1, 3, 5, 6, 7, 9, 11, 13		
I HD+N	Total harmonic distortion plus noise	vs Output power	2, 4, 8, 10, 12, 14		
	Supply ripple rejection ratio	vs Frequency	15, 16		
V _n	Output noise voltage	vs Frequency	17, 18		
	Crosstalk	vs Frequency	19–24		
	Shutdown attenuation	vs Frequency	25, 26		
	Open-loop gain and phase margin	vs Frequency	27, 28		
	Output power	vs Load resistance	29, 30		
I _{DD}	Supply current	vs Supply voltage	31		
SNR	Signal-to-noise ratio	vs Voltage gain	32		
	Power dissipation/amplifier	vs Load power	33, 34		

Submit Documentation Feedback



TOTAL HARMONIC DISTORTION + NOISE vs



TOTAL HARMONIC DISTORTION + NOISE vs OUTPUT POWER

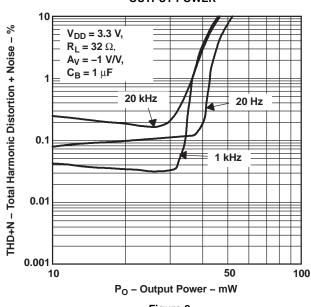


Figure 2.

TOTAL HARMONIC DISTORTION + NOISE

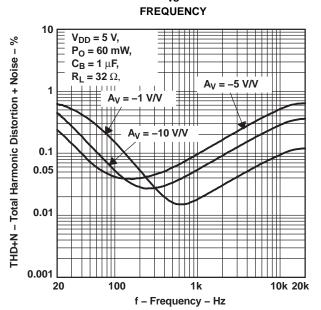


Figure 3.

TOTAL HARMONIC DISTORTION + NOISE vs

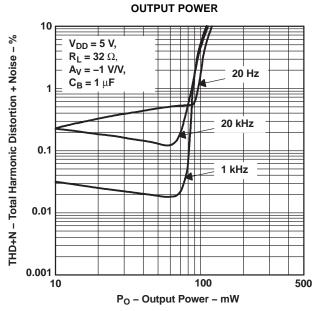
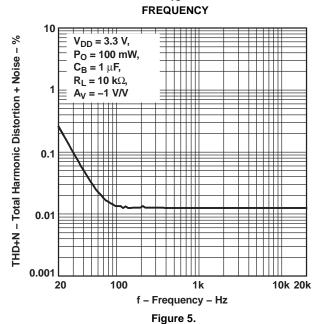


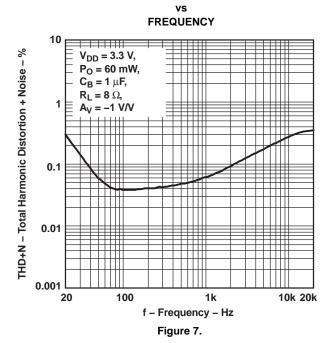
Figure 4.



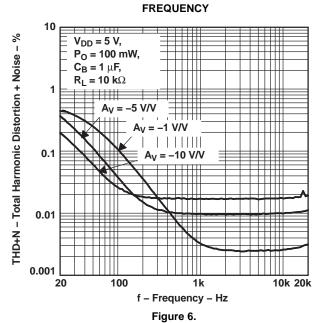
TOTAL HARMONIC DISTORTION + NOISE



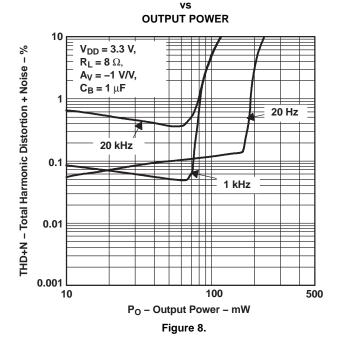
TOTAL HARMONIC DISTORTION + NOISE



TOTAL HARMONIC DISTORTION + NOISE vs

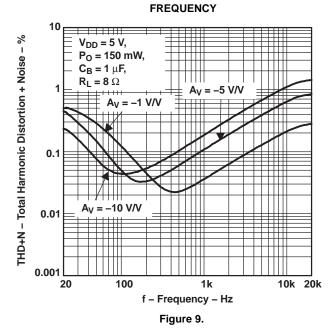


TOTAL HARMONIC DISTORTION + NOISE

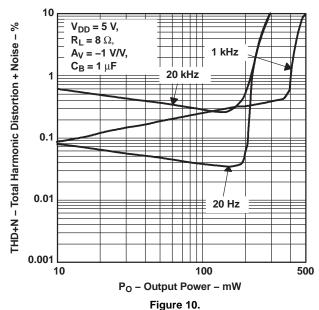




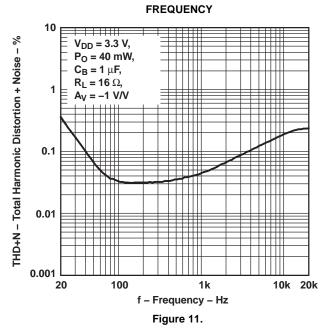
TOTAL HARMONIC DISTORTION + NOISE vs



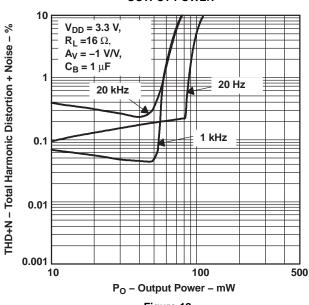
TOTAL HARMONIC DISTORTION + NOISE vs OUTPUT POWER



TOTAL HARMONIC DISTORTION + NOISE vs



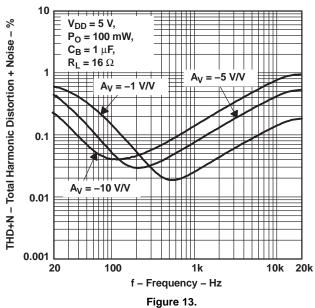
TOTAL HARMONIC DISTORTION + NOISE vs OUTPUT POWER



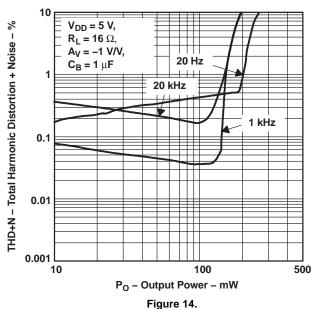


TOTAL HARMONIC DISTORTION + NOISE

FREQUENCY

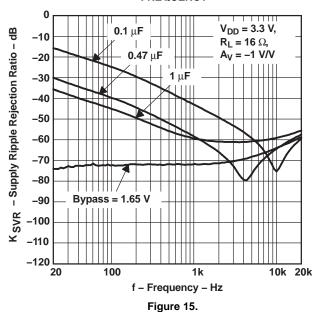


TOTAL HARMONIC DISTORTION + NOISE vs OUTPUT POWER



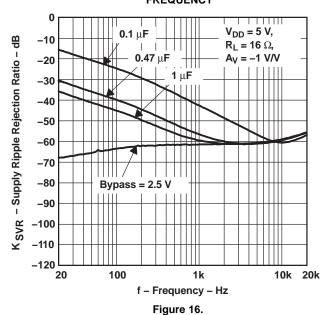
SUPPLY RIPPLE REJECTION RATIO

FREQUENCY



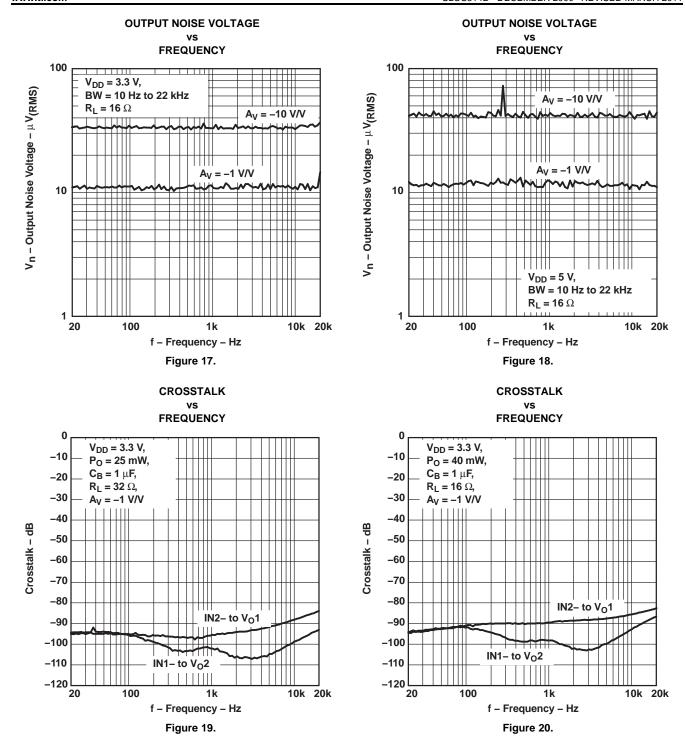
SUPPLY RIPPLE REJECTION RATIO

FREQUENCY

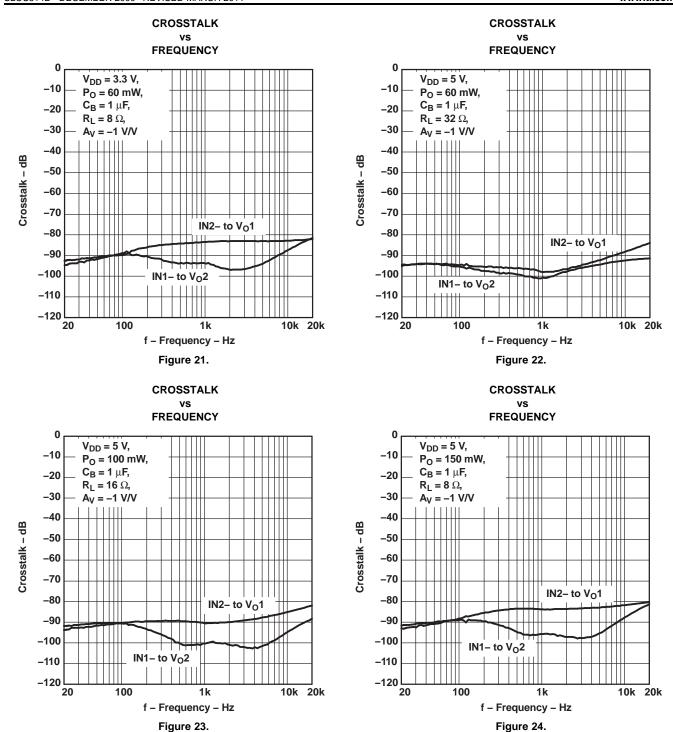


Submit Documentation Feedback









SHUTDOWN ATTENUATION



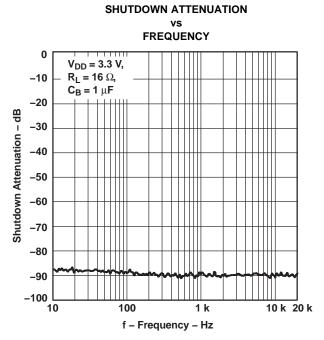


Figure 25.

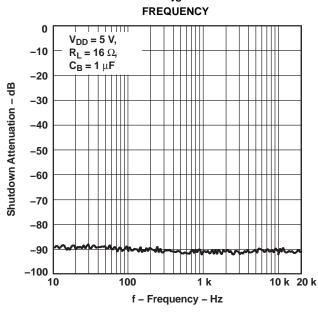
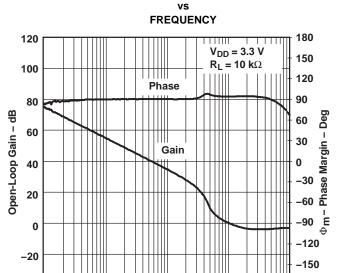


Figure 26.

OPEN-LOOP GAIN AND PHASE MARGIN



f – Frequency – Hz Figure 27.

1 M

100 k

OPEN-LOOP GAIN AND PHASE MARGIN vs FREQUENCY

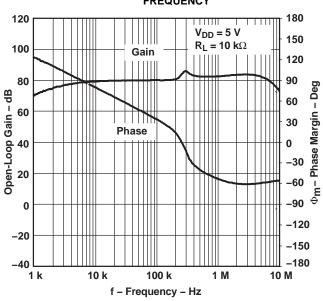


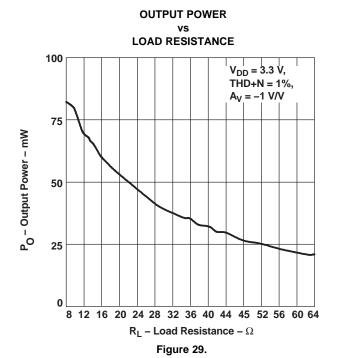
Figure 28.

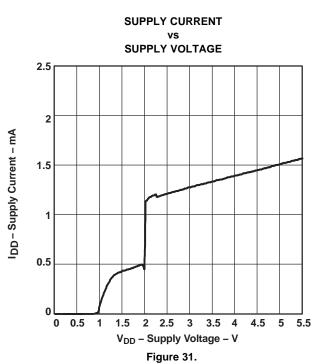
10 k

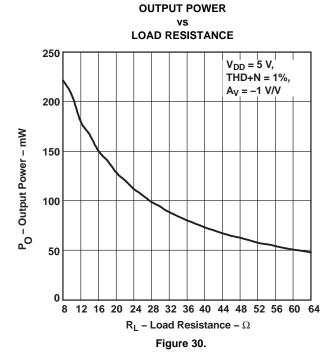
–40 └─ 1 k -180

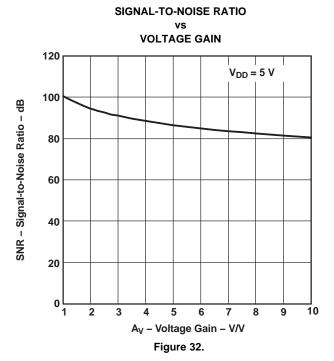
10 M



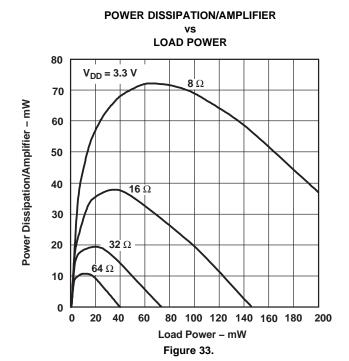


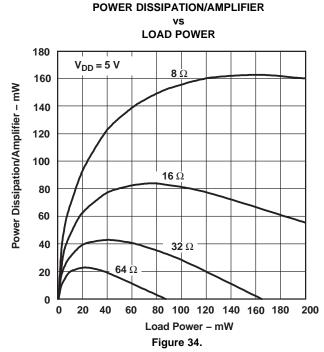














APPLICATION INFORMATION

GAIN SETTING RESISTORS, R_f and R_i

The gain for the TPA6110A2 is set by resistors R_f and R_i according to Equation 1.

$$Gain = -\left(\frac{R_f}{R_i}\right)$$
 (1)

Given that the TPA6110A2 is a MOS amplifier, the input impedance is very high. Consequently input leakage currents are not generally a concern. However, noise in the circuit increases as the value of $R_{\rm f}$ increases. In addition, a certain range of $R_{\rm f}$ values is required for proper start-up operation of the amplifier. Considering these factors, it is recommended that the effective impedance seen by the inverting node of the amplifier be set between 5 $k\Omega$ and 20 $k\Omega$. The effective impedance is calculated using Equation 2.

Effective Impedance =
$$\frac{R_f R_i}{R_f + R_i}$$
 (2)

For example, if the input resistance is 20 $k\Omega$ and the feedback resistor is 20 $k\Omega,$ the gain of the amplifier is -1, and the effective impedance at the inverting terminal is 10 $k\Omega,$ a value within the recommended range.

For high performance applications, metal-film resistors are recommended because they tend to have lower noise levels than carbon resistors. For values of $R_{\rm f}$ above 50 k Ω , the amplifier tends to become unstable due to a pole formed from $R_{\rm f}$ and the inherent input capacitance of the MOS input structure. For this reason, a small compensation capacitor of approximately 5 pF should be placed in parallel with $R_{\rm f}$. This, in effect, creates a low-pass filter network with the cutoff frequency defined by Equation 3.

$$f_{c(lowpass)} = \frac{1}{2\pi R_f C_F}$$
 (3)

For example, if R_f is 100 $k\Omega$ and C_F is 5 pF then $f_{c(lowpass)}$ is 318 kHz, which is well outside the audio range.

INPUT CAPACITOR, Ci

In the typical application, an input capacitor, C_i , is required to allow the amplifier to bias the input signal to the proper dc level for optimum operation. In this case, C_i and R_i form a high-pass filter with the corner frequency determined in Equation 4.

$$f_{c(highpass)} = \frac{1}{2\pi R_i C_i}$$
 (4)

The value of C_i directly affects the bass (low frequency) performance of the circuit. Consider the example where R_i is 20 k Ω and the specification calls for a flat bass response down to 20 Hz. Equation 4 is reconfigured as Equation 5.

$$C_{i} = \frac{1}{2\pi R_{i} f_{c(highpass)}}$$
 (5)

In this example, C_i is 0.40 μF , so one would likely choose a value in the range of 0.47 μF to 1 μF . A further consideration for this capacitor is the leakage path from the input source through the input network formed by R_i , C_i , and the feedback resistor (R_f) to the load. This leakage current creates a dc offset voltage at the input to the amplifier that reduces useful headroom, especially in high-gain applications (gain >10). For this reason a low-leakage tantalum or ceramic capacitor is the best choice. When polarized capacitors are used, connect the positive side of the capacitor to the amplifier input in most applications. The dc level there is held at $V_{DD}/2$ —likely higher than the source dc level. It is important to confirm the capacitor polarity in the application.

POWER SUPPLY DECOUPLING, C(S)

The TPA6110A2 is a high-performance CMOS audio amplifier that requires adequate power-supply decoupling to minimize the output total harmonic distortion (THD). Power-supply decoupling also prevents oscillations when long lead lengths are used between the amplifier and the speaker. The optimum decoupling is achieved by using two capacitors of different types that target different types of noise on the power supply leads. For higher frequency transients, spikes, or digital hash on the line, a good equivalent-series-resistance (ESR) capacitor, typically 0.1 µF, placed as close as possible to the device V_{DD} lead, works best. For filtering lower-frequency noise signals, a larger aluminum electrolytic capacitor of 10 µF or greater placed near the power amplifier is recommended.

Submit Documentation Feedback



MIDRAIL BYPASS CAPACITOR, C(B)

The midrail bypass capacitor, $C_{(B)}$, serves several important functions. During start up, $C_{(B)}$ determines the rate at which the amplifier starts up. This helps to push the start-up pop noise into the subaudible range (so low it can not be heard). The second function is to reduce noise produced by the power supply caused by coupling into the output drive signal. This noise is from the midrail generation circuit internal to the amplifier. The capacitor is fed from a 230-k Ω source inside the amplifier. To keep the start-up pop as low as possible, maintain the relationship shown in Equation 6.

$$\frac{1}{\left(C_{(B)} \times 230 \text{ k}\Omega\right)} \leq \frac{1}{\left(C_{i}R_{i}\right)} \tag{6}$$

Consider an example circuit where $C_{(B)}$ is 1 μ F, C_i is 1 μ F, and R_i is 20 $k\Omega$. Substituting these values into the equation 9 results in: $6.25 \le 50$ which satisfies the rule. Bypass capacitor, $C_{(B)}$, values of 0.1 μ F to 1 μ F ceramic or tantalum low-ESR capacitors are recommended for the best THD and noise performance.

OUTPUT COUPLING CAPACITOR, C(C)

In a typical single-supply, single-ended (SE) configuration, an output coupling capacitor $(C_{(C)})$ is required to block the dc bias at the output of the amplifier, thus preventing dc currents in the load. As with the input coupling capacitor, the output coupling capacitor and impedance of the load form a high-pass filter governed by Equation 7.

$$f_{C} = \frac{1}{2\pi R_{L} C_{(C)}} \tag{7}$$

The main disadvantage, from a performance standpoint, is that the typically-small load impedance drives the low-frequency corner higher. Large values of $C_{(C)}$ are required to pass low frequencies into the load. Consider the example where a $C_{(C)}$ of 68 μF is chosen and loads vary from 32 Ω to 47 k Ω . Table 1 summarizes the frequency response characteristics of each configuration.

Table 1. Common Load Impedances vs Low-Frequency Output Characteristics in SE Mode

R _L	C _(C)	LOWEST FREQUENCY
32 Ω	68 µF	73 Hz
10,000 Ω	68 µF	0.23 Hz
47,000 Ω	68 µF	0.05 Hz

As Table 1 indicates, headphone response is adequate, and drive into line level inputs (a home stereo for example) is very good.

The output coupling capacitor required in single-supply SE mode also places additional constraints on the selection of other components in the amplifier circuit. With the rules described earlier still valid, add the following relationship:

$$\frac{1}{\left(C_{(B)} \times 230 \text{ k}\Omega\right)} \leq \frac{1}{\left(C_{i}R_{i}\right)} \ll \frac{1}{R_{L}C_{(C)}}$$
(8)

USING LOW-ESR CAPACITORS

Low-ESR capacitors are recommended throughout this application. A real capacitor can be modeled simply as a resistor in series with an ideal capacitor. The voltage drop across this resistor minimizes the beneficial effects of the capacitor in the circuit. The lower the equivalent value of this resistance, the more the real capacitor behaves like an ideal capacitor.

5-V VERSUS 3.3-V OPERATION

The TPA6110A2 was designed for operation over a supply range of 2.5 V to 5.5 V. This data sheet provides full specifications for 5-V and 3.3-V operation, since these are considered to be the two most common supply voltages. There are no special considerations for 3.3-V versus 5-V operation as far as supply bypassing, gain setting, or stability. The most important consideration is that of output power. Each amplifier in theTPA6110A2 can produce a maximum voltage swing of $V_{DD}-1$ V. This means, for 3.3-V operation, clipping starts to occur when $V_{O(PP)}=2.3$ V as opposed when $V_{O(PP)}=4$ V while operating at 5 V. The reduced voltage swing subsequently reduces maximum output power into the load before distortion becomes significant.



REVISION HISTORY

CI	nanges from Original (December 2000) to Revision A	Page
•	Change the DC ELECTRICAL CHARACTERISTICS table From T_A = 25°C, V_{DD} = 3.3 V To: T_A = 25°C, V_{DD} = 2.5 V, updated values	
•	Change the DC ELECTRICAL CHARACTERISTICS table From $T_A = 25^{\circ}C$, $V_{DD} = 5$ V To: $T_A = 25^{\circ}C$, $V_{DD} = 5.5$ V, updated values	3
•	Changed Figure 8, From: $R_L = 8k\Omega$ To: $R_L = 8\Omega$	<u>6</u>
•	Changed Figure 24, From: frequency limit at 1M To: frequency limit at 20K	10
<u>.</u>	Changed Figure 25, From: frequency limit at 1M To: frequency limit at 20K	11
CI	nanges from Revision A (September 2004) to Revision B	Page
	Changed the DC Electrical Characteristice ($V_{DD} = 2.5V$) for $I_{DD(SD)}$ From: Typ = 10 Max = 50 To: Typ = 1 Max = 10 .	3
•	Changed the DC Electrical Characteristice ($V_{DD} = 5.5V$) for $I_{DD(SD)}$ From: Typ = 60 Max = 100 To: Typ = 1 Max = 10	3

www.ti.com 11-Nov-2025

PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
TPA6110A2DGN	Active	Production	HVSSOP (DGN) 8	80 TUBE	Yes	NIPDAU NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	AIZ
TPA6110A2DGN.A	Active	Production	HVSSOP (DGN) 8	80 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AIZ
TPA6110A2DGNG4	Active	Production	HVSSOP (DGN) 8	80 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AIZ
TPA6110A2DGNR	Active	Production	HVSSOP (DGN) 8	2500 LARGE T&R	Yes	NIPDAU NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	AIZ
TPA6110A2DGNR.A	Active	Production	HVSSOP (DGN) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	AIZ

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

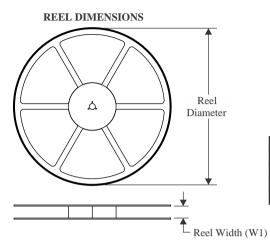
⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

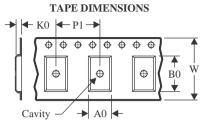
⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

www.ti.com 23-May-2025

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPA6110A2DGNR	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TPA6110A2DGNR	HVSSOP	DGN	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

www.ti.com 23-May-2025



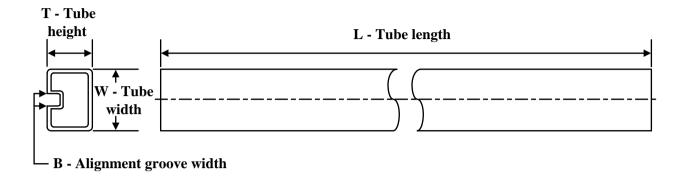
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPA6110A2DGNR	HVSSOP	DGN	8	2500	358.0	335.0	35.0
TPA6110A2DGNR	HVSSOP	DGN	8	2500	364.0	364.0	27.0

PACKAGE MATERIALS INFORMATION

www.ti.com 23-May-2025

TUBE



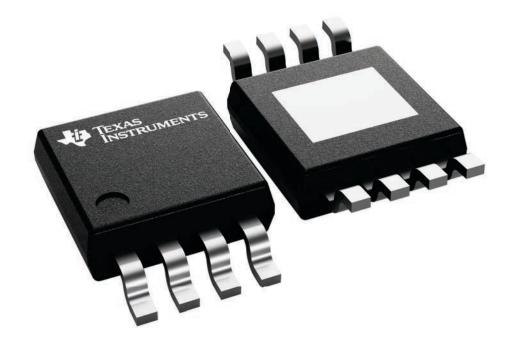
*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
TPA6110A2DGN	DGN	HVSSOP	8	80	330	6.55	500	2.88
TPA6110A2DGN.A	DGN	HVSSOP	8	80	330	6.55	500	2.88
TPA6110A2DGNG4	DGN	HVSSOP	8	80	330	6.55	500	2.88

3 x 3, 0.65 mm pitch

SMALL OUTLINE PACKAGE

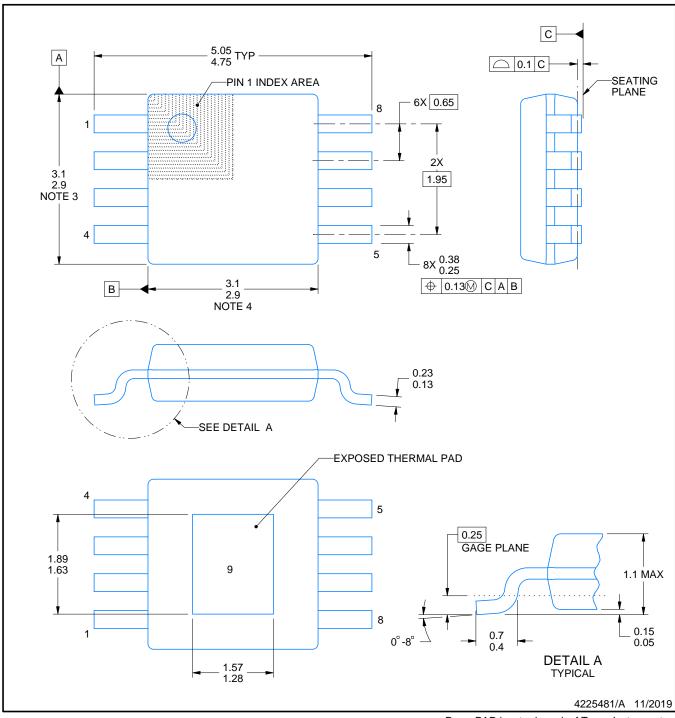
This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



INSTRUMENTS www.ti.com

$\textbf{PowerPAD}^{^{\text{\tiny{TM}}}}\,\textbf{VSSOP - 1.1 mm max height}$

SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

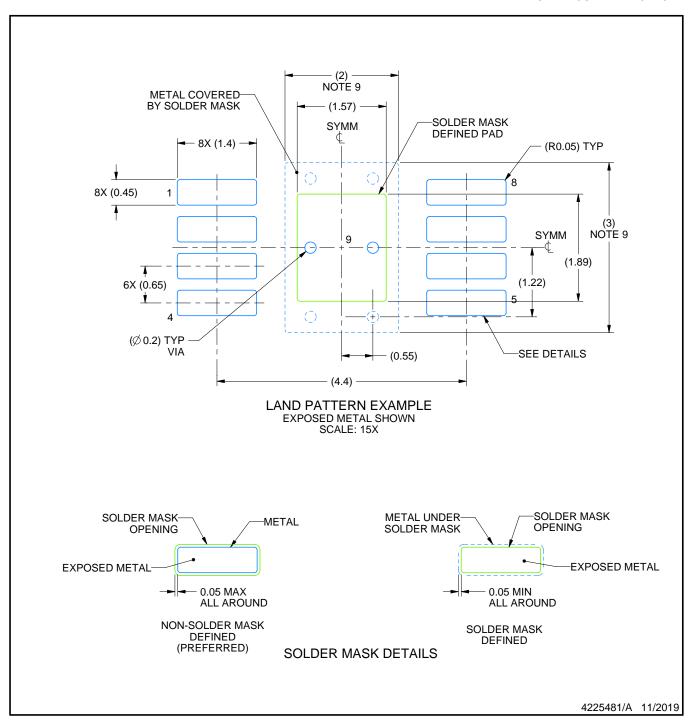
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE

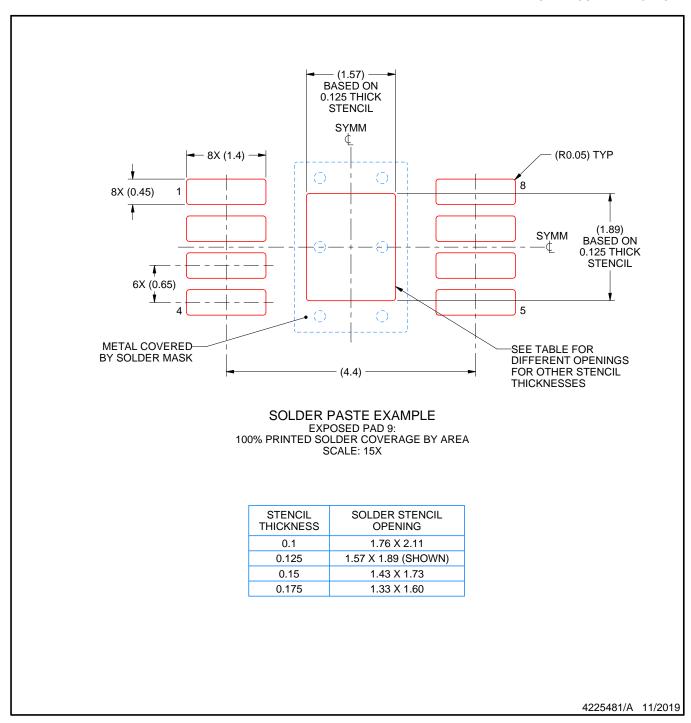


NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



SMALL OUTLINE PACKAGE



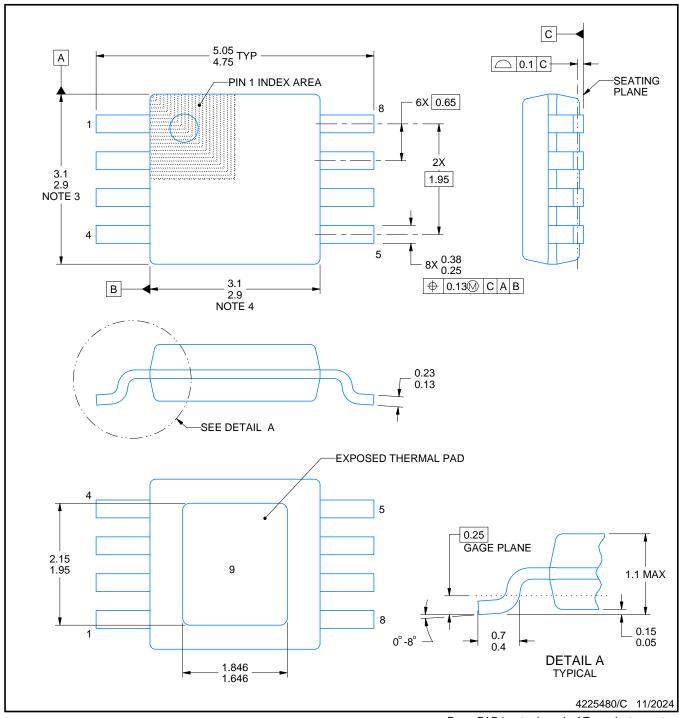
NOTES: (continued)

- 10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 11. Board assembly site may have different recommendations for stencil design.



PowerPAD[™] HVSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

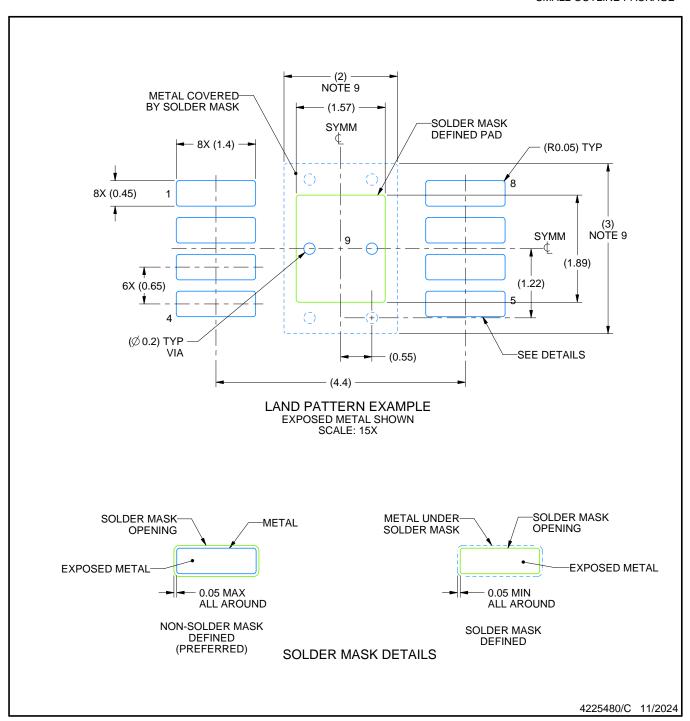
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE

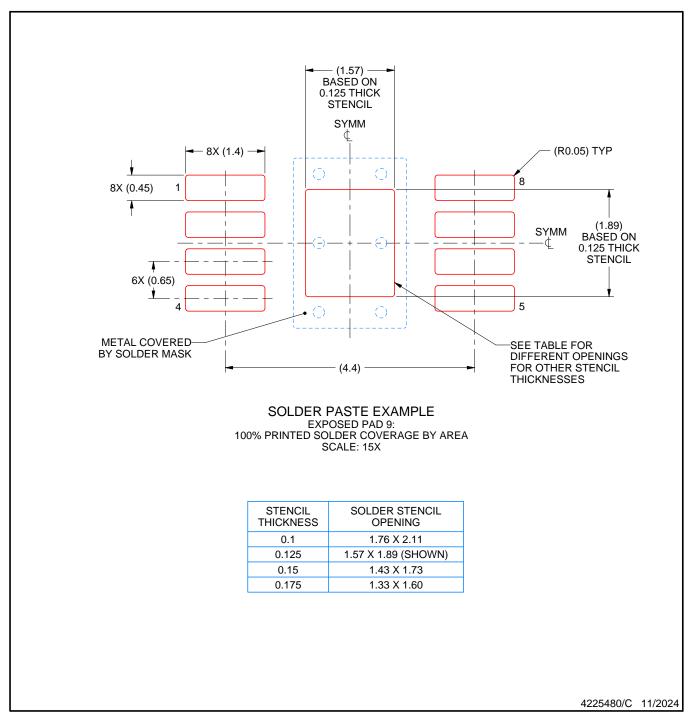


NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 11. Board assembly site may have different recommendations for stencil design.



IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025